



Test Report

NO: GSI09120801608

Date: Dec. 17, 2009

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Customer: HongKong Tenow International Ltd.

Address: UnitC-8A, Shennan Garden Building, High-Tech Park, Nanshan District, Shenzhen, China

Report on the submitted sample said to be

Sample name: Prof Red Series DVB-S2 7300

Model: Prof7300

Item/Lot NO: /

Material: /

Buyer: /

Supplier: /

Manufacturer: /

Reports received date: Dec. 10-17, 2009

Requisition: To combine the test reports for the submitted sample

Conclusion: All reports as specified client, determine the Lead, Cadmium, Mercury, Hexavalent Chromium and/or PBB&PBDE content in the submitted sample which are restricted in Directive 2002/95/EC (ROHS).

*****FOR FURTHER DETAILS, PLEASE REFER TO THE FOLLOWING PAGE(S) *****

Signed for GSI Ltd.

Written by :

Inspected by:

Approved by :

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Shenzhen GSI Electronic Technology Co · Ltd

Address: Room 616 , XianKeJiDian Building , BaGuaSi Road, Shenzhen , China
Tel:(86)755-25844177 Fax:(86)755-25844877 Http://www.szjisihai.com



Test Results:

No.	Component	Material	Issue Body	Report No & Issue Date	Test Data (PPM)
1		Metal sheet	SGS	SH9093028/CHEM Date: May. 27, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: Negative
2		Screw	SGS	GZ0910153815/ CHEM Date: OCT. 19, 2009	Cd: N.D. Pd: 26 Hg: N.D. Cr6: Negative
3		PCB	SGS	SH9032784/CHEM Date: MAR. 09, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D. PBBS: N.D. PBDES: N.D.
4		Soldering tin	SGS	SH9023320/CHEM Date: FEB. 23, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
5		Chip capacitor C133	SGS	TJTC 0904985/CHEM Date: Apr.20, 2009	Cd: N.D. Pd: 16 Hg: N.D. Cr6: N.D.
6	resistors	Chip resistors R64	SGS	SH9088898/CHEM Date: May. 16, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
		Chip resistors FB5			Cd: 10.1 Pd: N.D. Hg: N.D. Cr6: N.D.
		Chip resistors FU1			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
7	transistor	Chip transistor T3	SGS	SH9005466/CHEM Date: Jan. 14, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
		Chip transistor T1			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.

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No.	Component	Material	Issue Body	Report No & Issue Date	Test Data (PPM)
8		R-array RP1	SGS	SH9041748/CHEM Date: Apr.16, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: Negative
9		Crystal	SGS	CE/2008/95054 Date: 2008/09/25	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
10	IC	Mixed all parts of body	SGS	CE/2007/38403 Date: 2007/04/09	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D. PBBS: N.D. PBDES: N.D
		Base material of ailver colored metal pin			Cd: N.D. Pd: 11 Hg: N.D. Cr6: Negative
		Plating layer of silver colored metal pin			Cd: N.D. Pd: 13 Hg: N.D. Cr6: Negative
11		Electrolytic capacitor	CTI	ZSR0904181109105C Date: 2009. 4. 23	Cd: N.D. Pd: 9mg/kg Hg: N.D. Cr6: N.D. PBBS: N.D. PBDES: N.D
12		Inductor	SGS	CANEC0900077001 Date: 13 Jan, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
13	STEREO JACK	Golden metal	SGS	CANEC0801469201 Date: 09. Apr, 2008	Cd: N.D. Pd: 28 Hg: N.D. Cr6: Negative
		Black plastic			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D. PBBS: N.D. PBDES: N.D

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No.	Component	Material	Issue Body	Report No & Issue Date	Test Data (PPM)
14	PLUG	Metal holder	SGS	GZ08110024/CHEM Date: NOV. 23, 2008	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: Negative
		Transparent plastic			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D PBBS: N.D. PBDES: N.D
		Insert needle			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: Negative
15		White label	SGS	SZ90403058-2.1 Date: APR. 10, 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D. PBBS: N.D. PBDES: N.D
16	Aluminium product	Small radiator	SGS	CANEC0801839802 Date: 24.Apr, 2008	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
		Large radiator			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
		Aluminium product			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
17		Chip capacitor C39	SGS	SZ085384/EC Date: MAY 01, 2008	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.
18	IC	The body of IC U2	SGS	SH9070328/CHEM Date: Jun 05 2009	Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D. PBBS: N.D. PBDES: N.D
		The pin of IC U2			Cd: N.D. Pd: N.D. Hg: N.D. Cr6: N.D.

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Note:

- N.D.=not detected
- ppm=mg/kg
- Photograph is included

Photograph of Sample



Prof Red Series DVB-S2 7300

End of Report

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